# ICS874001I-02

## DATA SHEET

## **General Description**

The ICS874001I-02 is a high performance Jitter Attenuator designed for use in PCI Express<sup>™</sup> systems. In some PCI Express systems, such as those found in desktop PCs, the PCI Express clocks are generated from a low bandwidth, high phase noise PLL frequency synthesizer. In these systems, a jitter attenuator may be required to attenuate high frequency random and deterministic jitter components from the PLL synthesizer and from the system board. The ICS874001I-02 has two different PLL bandwidth modes: 2MHz and 3MHz. The 2MHz mode will provide maximum jitter attenuation, but with higher PLL tracking skew and spread spectrum modulation from the motherboard synthesizer may be attenuated. The 3MHz bandwidth provides the best tracking skew and will pass most spread profiles, but the jitter attenuation will not be as good as the lower bandwidth mode. The 874001I-02 can be set for different modes using the F\_SELx pins, as shown in Table 3C.

The ICS874001I-02 uses IDT's 3<sup>RD</sup> Generation FemtoClock<sup>®</sup> PLL technology to achieve the lowest possible phase noise. The device is packaged in a small 20-pin TSSOP package, making it ideal for use in space constrained applications such as PCI Express add-in cards.

### **Features**

- One differential LVDS output pair
- One differential clock input
- CLK, nCLK can accept the following differential input levels: LVPECL, LVDS, LVHSTL, HCSL, SSTL
- Input frequency range: 98MHz to 128MHz
- Output frequency range: 98MHz to 640MHz
- VCO range: 490MHz 640MHz
- Cycle-to-cycle jitter: 15ps (maximum), 3.3V
- RMS period jitter: 3ps (maximum), 3.3V
- Two bandwidth modes allow the system designer to make jitter attenuation/tracking skew design trade-offs
- Full 3.3V or 2.5V operating supply
- -40°C to 85°C ambient operating temperature
- Available in lead-free (RoHS 6) package

#### PLL Bandwidth Control Table

| BW_SEI |
|--------|
|--------|

- 0 = PLL Bandwidth: 2MHz (default)
- 1 = PLL Bandwidth: 3MHz

#### PLL\_SEL Control Table

| PLL_SEL           |
|-------------------|
| 0 = Bypass        |
| 1 = VCO (default) |

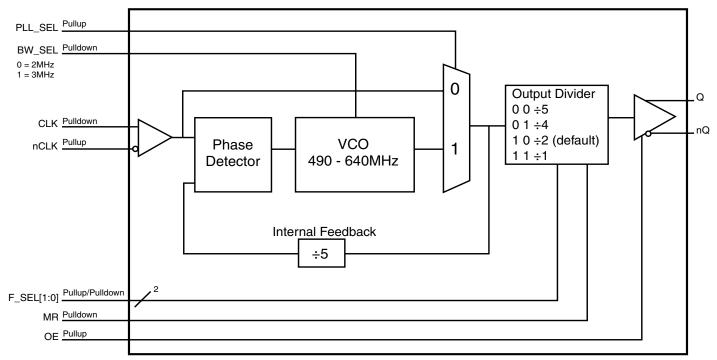
## **Pin Assignment**

| PLL_SEL          | 1  | 20 🗆 nc   |
|------------------|----|-----------|
| nc               | 2  | 19 🗖 Vddo |
| nc               | 3  | 18 🗖 Q    |
| nc               | 4  | 17 🗖 nQ   |
| MR               | 5  | 16 🗖 nc   |
| BW_SEL           | 6  | 15 🗖 nc   |
| F_SEL1           | 7  | 14 🛛 GND  |
| V <sub>DDA</sub> | 8  | 13 🔲 nCLK |
| F_SEL0           | 9  | 12 🛛 CLK  |
| V <sub>DD</sub>  | 10 | 11 🗆 OE   |
|                  |    |           |

#### ICS874001I-02 20-Lead TSSOP 6.5mm x 4.4mm x 0.925mm package body G Package Top View

# RENESAS

## **Block Diagram**



# Table 1. Pin Descriptions

| Number                 | Name             |        | Гуре     | Description   |
|------------------------|------------------|--------|----------|---|
| 1                      | PLL_SEL          | Input  | Pullup   | PLL select pin. When LOW, bypasses the VCO. When HIGH selects VCO. LVCMOS/LVTTL interface levels.   |
| 2, 3, 4,<br>15, 16, 20 | nc               | Unused |          | No connect.   |
| 5                      | MR               | Input  | Pulldown | Active High Master Reset. When logic HIGH, the internal dividers are reset causing the true output Q to go LOW and the inverted output nQ to go HIGH. When logic LOW, the internal dividers and the outputs are enabled. LVCMOS/LVTTL interface levels. |
| 6                      | BW_SEL           | Input  | Pulldown | PLL Bandwidth select pin. LVCMOS/LVTTL interface levels.<br>See Table 3B.   |
| 7                      | F_SEL1           | Input  | Pullup   | Frequency select pin. See Table 3C. LVCMOS/LVTTL interface levels.  |
| 8                      | V <sub>DDA</sub> | Power  |          | Analog supply pin.  |
| 9                      | F_SEL0           | Input  | Pulldown | Frequency select pin. See Table 3C. LVCMOS/LVTTL interface levels.  |
| 10                     | V <sub>DD</sub>  | Power  |          | Core supply pin.  |
| 11                     | OE               | Input  | Pullup   | Output enable. When HIGH, outputs are enabled. When LOW, forces outputs to High-Impedance state. LVCMOS/LVTTL interface levels. See Table 3A.   |
| 12                     | CLK              | Input  | Pulldown | Non-inverting differential clock input.   |
| 13                     | nCLK             | Input  | Pullup   | Inverting differential clock input.   |
| 14                     | GND              | Power  |          | Power supply ground.  |
| 17, 18                 | nQ, Q            | Output |          | Differential output pair. LVDS interface levels.  |
| 19                     | V <sub>DDO</sub> | Power  |          | Output supply pin.  |

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

## **Table 2. Pin Characteristics**

| Symbol                | Parameter               | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------------|-------------------------|-----------------|---------|---------|---------|-------|
| C <sub>IN</sub>       | Input Capacitance       |                 |         | 4       |         | pF    |
| R <sub>PULLUP</sub>   | Input Pullup Resistor   |                 |         | 51      |         | kΩ    |
| R <sub>PULLDOWN</sub> | Input Pulldown Resistor |                 |         | 51      |         | kΩ    |

# **Function Tables**

 Table 3A. Output Enable Function Table

| Inputs | Outputs        |
|--------|----------------|
| OE     | Q, nQ          |
| 0      | High-Impedance |
| 1      | Enabled        |

### Table 3B. PLL Bandwidth Control Table

| Inputs |                |
|--------|----------------|
| BW_SEL | PLL Bandwidth  |
| 0      | 2MHz (default) |
| 1      | 3MHz           |

### Table 3C. F\_SELx Function Table

| Input Frequency |        | Inputs |         |                        |
|-----------------|--------|--------|---------|------------------------|
| (MHz)           | F_SEL1 | F_SEL0 | Divider | Output Frequency (MHz) |
| 100             | 0      | 0      | ÷5      | 100                    |
| 100             | 0      | 1      | ÷4      | 125                    |
| 100             | 1      | 0      | ÷2      | 250 (default)          |
| 100             | 1      | 1      | ÷1      | 500                    |

## **Absolute Maximum Ratings**

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

| Item  | Rating                          |
|---|---------------------------------|
| Supply Voltage, V <sub>DD</sub>                               | 4.6V                            |
| Inputs, V <sub>I</sub>  | -0.5V to V <sub>DD</sub> + 0.5V |
| Outputs, I <sub>O</sub><br>Continuos Current<br>Surge Current | 10mA<br>15mA                    |
| Package Thermal Impedance, $\theta_{JA}$                      | 86.7°C/W (0 mps)                |
| Storage Temperature, T <sub>STG</sub>                         | -65°C to 150°C                  |

## **DC Electrical Characteristics**

### Table 4A. Power Supply DC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ , $T_A = -40^{\circ}C$ to $85^{\circ}C$

| Symbol           | Parameter             | Test Conditions | Minimum                | Typical | Maximum         | Units |
|------------------|-----------------------|-----------------|------------------------|---------|-----------------|-------|
| V <sub>DD</sub>  | Core Supply Voltage   |                 | 3.135                  | 3.3     | 3.465           | V     |
| V <sub>DDA</sub> | Analog Supply Voltage |                 | V <sub>DD</sub> – 0.12 | 3.3     | V <sub>DD</sub> | V     |
| V <sub>DDO</sub> | Output Supply Voltage |                 | 3.135                  | 3.3     | 3.465           | V     |
| I <sub>DD</sub>  | Power Supply Current  |                 |                        |         | 72              | mA    |
| I <sub>DDA</sub> | Analog Supply Current |                 |                        |         | 12              | mA    |
| I <sub>DDO</sub> | Output Supply Current |                 |                        |         | 24              | mA    |

#### Table 4B. Power Supply DC Characteristics, $V_{DD} = V_{DDO} = 2.5V \pm 5\%$ , $T_A = -40^{\circ}C$ to $85^{\circ}C$

| Symbol           | Parameter             | Test Conditions | Minimum                | Typical | Maximum         | Units |
|------------------|-----------------------|-----------------|------------------------|---------|-----------------|-------|
| V <sub>DD</sub>  | Core Supply Voltage   |                 | 2.375                  | 2.5     | 2.625           | V     |
| V <sub>DDA</sub> | Analog Supply Voltage |                 | V <sub>DD</sub> – 0.12 | 2.5     | V <sub>DD</sub> | V     |
| V <sub>DDO</sub> | Output Supply Voltage |                 | 2.375                  | 2.5     | 2.625           | V     |
| I <sub>DD</sub>  | Power Supply Current  |                 |                        |         | 70              | mA    |
| I <sub>DDA</sub> | Analog Supply Current |                 |                        |         | 12              | mA    |
| I <sub>DDO</sub> | Output Supply Current |                 |                        |         | 22              | mA    |

| Symbol          | Parameter          |                        | Test Conditions                                      | Minimum | Typical | Maximum               | Units |
|-----------------|--------------------|------------------------|--|---------|---------|-----------------------|-------|
| V <sub>IH</sub> | Input High Voltago |                        | V <sub>DD</sub> = 3.465V                             | 2       |         | V <sub>DD</sub> + 0.3 | V     |
|                 | Input High Voltage |                        | V <sub>DD</sub> = 2.625V                             | 1.7     |         | V <sub>DD</sub> + 0.3 | V     |
|                 | Input Low Voltage  |                        | V <sub>DD</sub> = 3.465V                             | -0.3    |         | 0.8                   | V     |
| V <sub>IL</sub> | Input Low Voltage  |                        | V <sub>DD</sub> = 2.625V                             | -0.3    |         | 0.7                   | V     |
|                 |                    | F_SEL0, MR,<br>BW_SEL  | V <sub>DD</sub> = V <sub>IN</sub> = 3.465V or 2.625V |         |         | 150                   | μA    |
| I <sub>IH</sub> | Input High Current | F_SEL1, OE,<br>PLL_SEL | V <sub>DD</sub> = V <sub>IN</sub> = 3.465V or 2.625V |         |         | 5                     | μA    |
|                 | Input Low Current  | F_SEL0, MR,<br>BW_SEL  | $V_{DD} = 3.465 V \text{ or } 2.625 V, V_{IN} = 0 V$ | -5      |         |                       | μA    |
| I <sub>IL</sub> | Input Low Current  | F_SEL1, OE,<br>PLL_SEL | $V_{DD}$ = 3.465V or 2.625V, $V_{IN}$ = 0V           | -150    |         |                       | μA    |

### Table 4C. LVCMOS/LVTTL DC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ or 2.5V $\pm 5\%$ , $T_A = -40^{\circ}$ C to 85°C

Table 4D. Differential DC Characteristics, V\_{DD} = V\_{DDO} = 3.3V ± 5% or 2.5V ± 5%, T<sub>A</sub> = -40°C to 85°C

| Symbol           | Parameter                            |  | Test Conditions  | Minimum   | Typical | Maximum                | Units |
|------------------|--------------------------------------|--|--|-----------|---------|------------------------|-------|
| IIH              | Input High Current                   | CLK  | $V_{DD} = V_{IN} = 3.465V \text{ or}$<br>2.625V        |           |         | 150                    | μA    |
|                  |                                      | $V_{DD} = V_{IN} = 3.465V \text{ or}$<br>2.625V        |  |           | 5       | μA                     |       |
| I <sub>IL</sub>  | Input Low Current CLK                | CLK  | $V_{DD} = 3.465V \text{ or } 2.625V,$<br>$V_{IN} = 0V$ | -5        |         |                        | μA    |
|                  |                                      | $V_{DD} = 3.465V \text{ or } 2.625V,$<br>$V_{IN} = 0V$ | -150   |           |         | μA                     |       |
| V <sub>PP</sub>  | Peak-to-Peak Voltag                  | je; NOTE 1   |  | 0.15      |         | 1.3                    | V     |
| V <sub>CMR</sub> | Common Mode Input Voltage; NOTE 1, 2 |  |  | GND + 0.5 |         | V <sub>DD</sub> – 0.85 | V     |

NOTE 1: V<sub>IL</sub> should not be less than -0.3V.

NOTE 2: Common mode input voltage is defined as V<sub>IH</sub>.

### Table 4E. LVDS DC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ , $T_A = -40^{\circ}C$ to $85^{\circ}C$

| Symbol          | Parameter                        | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------|----------------------------------|-----------------|---------|---------|---------|-------|
| V <sub>OD</sub> | Differential Output Voltage      |                 | 300     | 390     | 480     | mV    |
| $\Delta V_{OD}$ | V <sub>OD</sub> Magnitude Change |                 |         |         | 50      | mV    |
| V <sub>OS</sub> | Offset Voltage                   |                 | 1.2     | 1.4     | 1.6     | V     |
| $\Delta V_{OS}$ | V <sub>OS</sub> Magnitude Change |                 |         |         | 50      | mV    |

| Symbol          | Parameter                        | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------|----------------------------------|-----------------|---------|---------|---------|-------|
| V <sub>OD</sub> | Differential Output Voltage      |                 | 300     | 390     | 480     | mV    |
| $\Delta V_{OD}$ | V <sub>OD</sub> Magnitude Change |                 |         |         | 50      | mV    |
| V <sub>OS</sub> | Offset Voltage                   |                 | 1.0     | 1.2     | 1.4     | V     |
| $\Delta V_{OS}$ | V <sub>OS</sub> Magnitude Change |                 |         |         | 50      | mV    |

### Table 4F. LVDS DC Characteristics, $V_{DD} = V_{DDO} = 2.5V \pm 5\%$ , $T_A = -40^{\circ}C$ to $85^{\circ}C$

## **AC Electrical Characteristics**

Table 5A. AC Characteristics,  $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ ,  $T_A = -40^{\circ}C$  to  $85^{\circ}C$ 

| Symbol                          | Parameter                     | Test Conditions | Minimum | Typical | Maximum | Units |
|---------------------------------|-------------------------------|-----------------|---------|---------|---------|-------|
| fout                            | Output Frequency              |                 | 98      |         | 640     | MHz   |
| <i>t</i> jit(cc)                | Cycle-to-Cycle Jitter; NOTE 1 |                 |         |         | 15      | ps    |
| <i>t</i> jit(per)               | RMS Period Jitter; NOTE 1     |                 |         | 2       | 3       | ps    |
| t <sub>R</sub> / t <sub>F</sub> | Output Rise/Fall Time         | 20% to 80%      | 230     |         | 470     | ps    |
| odo                             |                               | N ≠ 1           | 47      |         | 53      | %     |
| odc                             | Output Duty Cycle             | N = 1           | 40      |         | 60      | %     |

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1: This parameter is defined in accordance with JEDEC Standard 65.

### Table 5B. AC Characteristics, $V_{DD} = V_{DDO} = 2.5V \pm 5\%$ , $T_A = -40^{\circ}C$ to $85^{\circ}C$

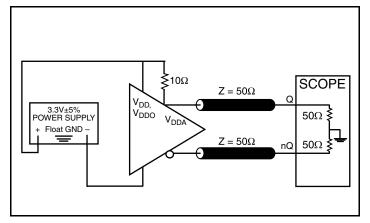
| Symbol                          | Parameter                     | Test Conditions | Minimum | Typical | Maximum | Units |
|---------------------------------|-------------------------------|-----------------|---------|---------|---------|-------|
| f <sub>OUT</sub>                | Output Frequency              |                 | 98      |         | 640     | MHz   |
| <i>t</i> jit(cc)                | Cycle-to-Cycle Jitter; NOTE 1 |                 |         |         | 20      | ps    |
| <i>t</i> jit(per)               | RMS Period Jitter; NOTE 1     |                 |         | 2       | 4       | ps    |
| t <sub>R</sub> / t <sub>F</sub> | Output Rise/Fall Time         | 20% to 80%      | 230     |         | 500     | ps    |
| odo                             |                               | N ≠ 1           | 47      |         | 53      | %     |
| odc                             | Output Duty Cycle             | N = 1           | 40      |         | 60      | %     |

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

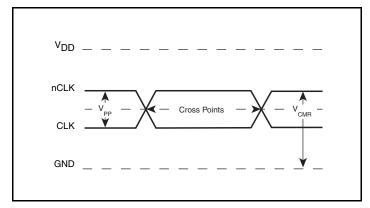
NOTE 1: This parameter is defined in accordance with JEDEC Standard 65.

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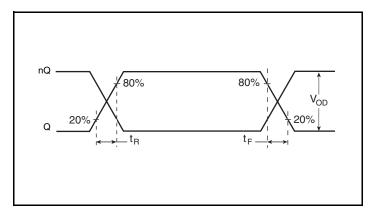
## **Parameter Measurement Information**



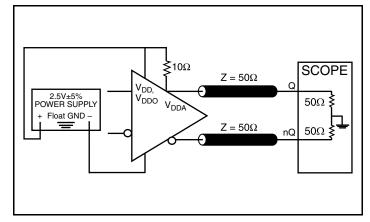
3.3V LVDS Output Load AC Test Circuit



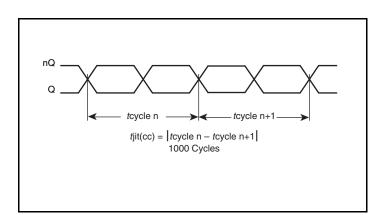
**Differential Input Level** 



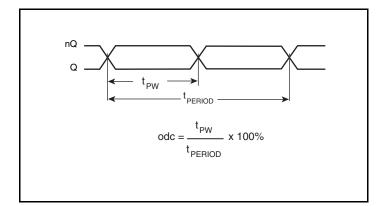
**Output Rise/Fall Time** 



2.5V LVDS Output Load AC Test Circuit



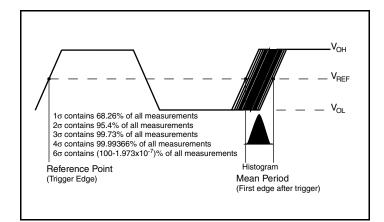
Cycle-to-Cycle Jitter

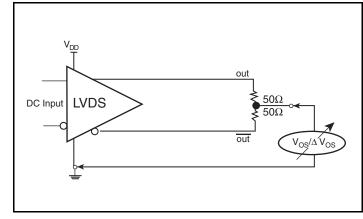


Output Duty Cycle/Pulse Width/Period

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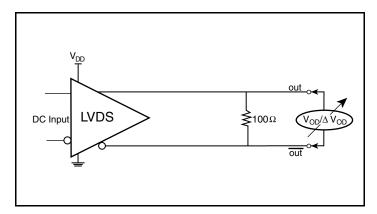
## Parameter Measurement Information, continued





**Offset Voltage Setup** 

**RMS Period Jitter** 



**Differential Output Voltage Setup** 

# **ApplicationS Information**

### **Power Supply Filtering Technique**

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. To achieve optimum jitter performance, power supply isolation is required. The ICS874001I-02 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL.  $V_{DD}$ ,  $V_{DDA}$  and  $V_{DDO}$  should be individually connected to the power supply plane through vias, and  $0.01\mu$ F bypass capacitors should be used for each pin. *Figure 1* illustrates this for a generic  $V_{DD}$  pin and also shows that  $V_{DDA}$  requires that an additional  $10\Omega$  resistor along with a  $10\mu$ F bypass capacitor be connected to the  $V_{DDA}$  pin.

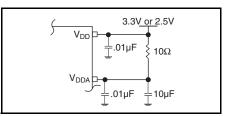


Figure 1. Power Supply Filtering

### Wiring the Differential Input to Accept Single-Ended Levels

*Figure 2* shows how a differential input can be wired to accept single ended levels. The reference voltage  $V_{REF} = V_{DD}/2$  is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible. The ratio of R1 and R2 might need to be adjusted to position the  $V_{REF}$  in the center of the input voltage swing. For example, if the input clock swing is 2.5V and  $V_{DD} = 3.3V$ , R1 and R2 value should be adjusted to set  $V_{REF}$  at 1.25V. The values below are for when both the single ended swing and  $V_{DD}$  are at the same voltage. This configuration requires that the sum of the output impedance of the driver (R0) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the transmission line impedance. For most 50 $\Omega$  applications, R3 and R4 can be 100 $\Omega$ . The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however V<sub>IL</sub> cannot be less than -0.3V and V<sub>IH</sub> cannot be more than V<sub>DD</sub> + 0.3V. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

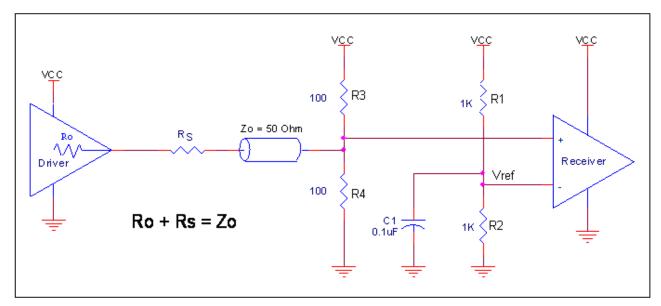
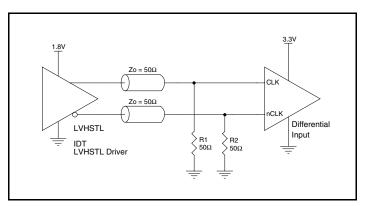


Figure 2. Recommended Schematic for Wiring a Differential Input to Accept Single-ended Levels

## **Differential Clock Input Interface**

The CLK /nCLK accepts LVDS, LVPECL, LVHSTL, SSTL, HCSL and other differential signals. Both signals must meet the V<sub>PP</sub> and V<sub>CMR</sub> input requirements. *Figures 3A to 3F* show interface examples for the CLK/nCLK input driven by the most common driver types. The input interfaces suggested here are examples only. Please consult with the



3A. CLK/nCLK Input Driven by an IDT Open Emitter LVHSTL Driver

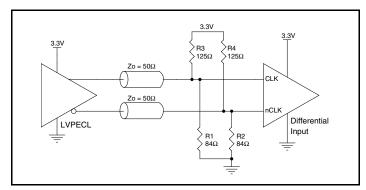


Figure 3C. CLK/nCLK Input Driven by a 3.3V LVPECL Driver

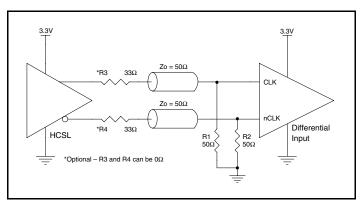
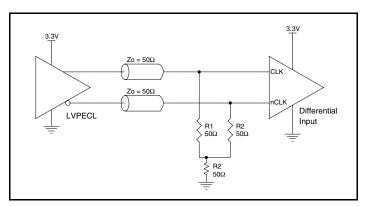
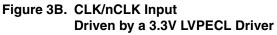


Figure 3E. CLK/nCLK Input Driven by a 3.3V HCSL Driver

vendor of the driver component to confirm the driver termination requirements. For example, in Figure 3A, the input termination applies for IDT open emitter LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.





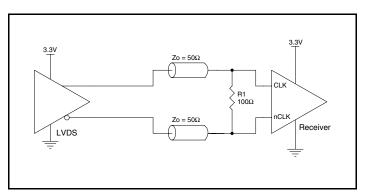


Figure 3D. CLK/nCLK Input Driven by a 3.3V LVDS Driver

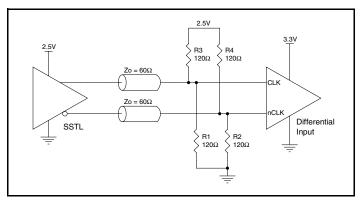


Figure 3F. CLK/nCLK Input Driven by a 2.5V SSTL Driver

### **Recommendations for Unused Input Pins**

#### Inputs:

#### **LVCMOS Control Pins**

All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A  $1k\Omega$  resistor can be used.

### **LVDS Driver Termination**

A general LVDS interface is shown in *Figure 4*. Standard termination for LVDS type output structure requires both a 100 $\Omega$  parallel resistor at the receiver and a 100 $\Omega$  differential transmission line environment. In order to avoid any transmission line reflection issues, the 100 $\Omega$  resistor must be placed as close to the receiver as possible. IDT offers a full line of LVDS compliant devices with two types of output structures: current source and voltage source. The standard

termination schematic as shown in Figure 4 can be used with either type of output structure. If using a non-standard termination, it is recommended to contact IDT and confirm if the output is a current source or a voltage source type structure. In addition, since these outputs are LVDS compatible, the amplitude and common mode input range of the input receivers should be verified for compatibility with the output.

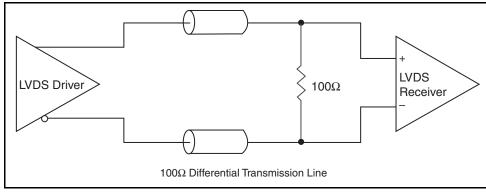


Figure 4. Typical LVDS Driver Termination

## Schematic Layout

Figure 5 shows an example of ICS874001I-02 application schematic. In this example, the device is operated at  $V_{DD}$  = 3.3V. The decoupling capacitors should be located as close as

possible to the power pin. The input is driven by a 3.3V LVPECL driver.

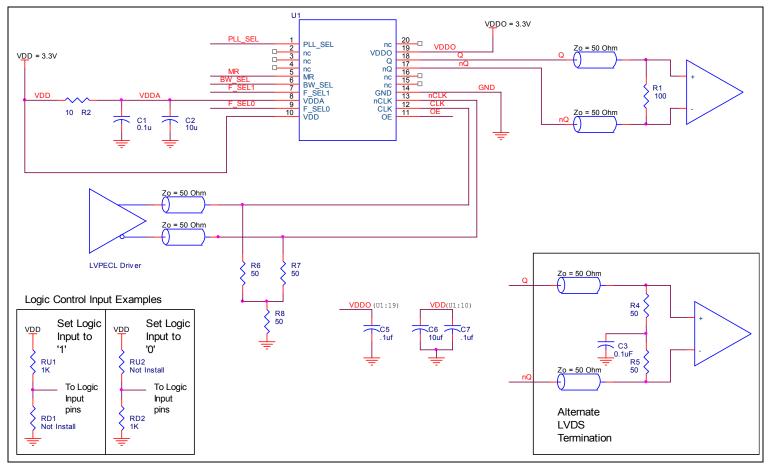


Figure 5. ICS874001I-02 Schematic Layout

## **Power Considerations**

This section provides information on power dissipation and junction temperature for theICS874001I-02. Equations and example calculations are also provided.

#### 1. Power Dissipation.

The total power dissipation for the ICS874001I-02 is the sum of the core power plus the analog power plus the power dissipated in the load(s). The following is the power dissipation for  $V_{DD} = 3.3V + 5\% = 3.465V$ , which gives worst case results.

- Power (core)<sub>MAX</sub> = V<sub>DD\_MAX</sub> \* (I<sub>DD\_MAX</sub> + I<sub>DDA\_MAX</sub>) = 3.465V \* (72mA + 12mA) = 291.06mW
- Power (outputs)<sub>MAX</sub> = V<sub>DDO MAX</sub> \* I<sub>DDO MAX</sub> = 3.465V \* 24mA = 83.16mW

Total Power\_MAX = 291.06mW + 83.16mW = 374.22mW

•

#### 2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj =  $\theta_{JA}$  \* Pd\_total + T<sub>A</sub>

Tj = Junction Temperature

 $\theta_{JA}$  = Junction-to-Ambient Thermal Resistance

Pd\_total = Total Device Power Dissipation (example calculation is in section 1 above)

T<sub>A</sub> = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance  $\theta_{JA}$  must be used. Assuming no air flow and a multi-layer board, the appropriate value is 86.7°C/W per Table 6 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

85°C + 0.374W \* 86.7°C/W = 117°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

#### Table 6. Thermal Resistance $\theta_{\text{JA}}$ for 20 Lead TSSOP, Forced Convection

| $	heta_{JA}$ by Velocity                    |          |          |          |  |  |  |
|---|----------|----------|----------|--|--|--|
| Meters per Second                           | 0        | 1        | 2.5      |  |  |  |
| Multi-Layer PCB, JEDEC Standard Test Boards | 86.7°C/W | 82.4°C/W | 80.2°C/W |  |  |  |

## **Reliability Information**

Table 7.  $\theta_{\text{JA}}$  vs. Air Flow Table for a 20 Lead TSSOP

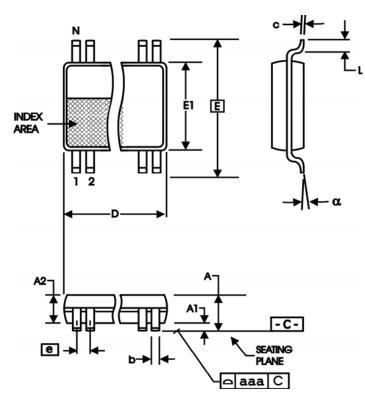
| $\theta_{JA}$ by Velocity                   |          |          |          |  |  |  |  |
|---|----------|----------|----------|--|--|--|--|
| Meters per Second                           | 0        | 1        | 2.5      |  |  |  |  |
| Multi-Layer PCB, JEDEC Standard Test Boards | 86.7°C/W | 82.4°C/W | 80.2°C/W |  |  |  |  |

### **Transistor Count**

The transistor count for ICS874001I-02 is: 1,608

# Package Outline and Package Dimensions

Package Outline - G Suffix for 20 Lead TSSOP



#### **Table 8 Package Dimensions**

| All Dimensions in Millimeters |         |         |  |  |  |  |  |
|-------------------------------|---------|---------|--|--|--|--|--|
| Symbol                        | Minimum | Maximum |  |  |  |  |  |
| N                             | 2       | 0       |  |  |  |  |  |
| Α                             |         | 1.20    |  |  |  |  |  |
| A1                            | 0.05    | 0.15    |  |  |  |  |  |
| A2                            | 0.80    | 1.05    |  |  |  |  |  |
| b                             | 0.19    | 0.30    |  |  |  |  |  |
| С                             | 0.09    | 0.20    |  |  |  |  |  |
| D                             | 6.40    | 6.60    |  |  |  |  |  |
| E                             | 6.40    | Basic   |  |  |  |  |  |
| E1                            | 4.30    | 4.50    |  |  |  |  |  |
| е                             | 0.65    | Basic   |  |  |  |  |  |
| L                             | 0.45    | 0.75    |  |  |  |  |  |
| α                             | 0°      | 8°      |  |  |  |  |  |
| aaa                           |         | 0.10    |  |  |  |  |  |

Reference Document: JEDEC Publication 95, MO-153



# **Ordering Information**

### Table 9. Ordering Information

| Part/Order Number | Marking      | Package                   | Shipping Packaging | Temperature   |
|-------------------|--------------|---------------------------|--------------------|---------------|
| 874001AGI-02LF    | ICS4001AI02L | "Lead-Free" 20 Lead TSSOP | Tube               | -40°C to 85°C |
| 874001AGI-02LFT   | ICS4001AI02L | "Lead-Free" 20 Lead TSSOP | 2500 Tape & Reel   | -40°C to 85°C |

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.



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